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A superhydrophobic chip based on SU-8 photoresist pillars suspended on a silicon nitride membrane†

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We developed a new generation of superhydrophobic chips optimized for probing ultrasmall sample quantities by X-ray scattering and fluorescence techniques. The chips are based on thin Si₃N₄ membranes with a tailored pattern of SU-8 photoresist pillars. Indeed, aqueous solution droplets can be evaporated and concentrated at predefined positions using a non-periodic pillar pattern. We demonstrated quantitatively the deposition and aggregation of gold glyconanoparticles from the evaporation of a nanomolar droplet in a small spot by raster X-ray nanofluorescence. Further, raster nanocrystallography of biological objects such as rod-like tobacco mosaic virus nanoparticles reveals crystalline macro-domain formation composed of highly oriented nanorods.

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Introduction

The sensitivity for probing low molecular concentrations of molecules or nanoparticles by X-ray scattering techniques can be considerably amplified by evaporating quasi contact-free droplets on superhydrophobic surfaces (SHSs).¹ Indeed, assembly processes at the interface of an evaporating droplet or the heterogeneity of its residue can be probed *in situ* by raster-scan X-ray diffraction (XRD) with μm - or sub- μm step-resolution defined by the focal spot size.¹ The absorption of SHSs based on standard silicon wafers of $\sim 500\ \mu\text{m}$ in thickness is, however, $\sim 82\%$ at a $\lambda = 0.1\ \text{nm}$ wavelength.² This poses no problem if the X-ray beam is oriented parallel to the surface when probing a droplet.¹ Raster-scan probing of residues in transmission geometry can also often be performed after separating the residue from the substrate.³ This is not possible for fragile residues such as filamentous extensions. Such morphologies are, however, of particular interest for XRD probing due to extensional flow alignment during the pinning transition.¹ An alternative is using SHSs based on thin Si-substrates with holes etched between the pillars.⁴ Although the X-ray absorption of a $\sim 50\ \mu\text{m}$ thick Si-substrate is only $\sim 16\%$, the correction for variation in absorption due

to the presence of holes requires elaborate post-processing software. Our aim was therefore to develop a SHS showing high quasi-homogeneous X-ray transmission and incorporating a periodic as well as non-periodic pillar patterning.^{5,6} This latter feature can help in keeping the droplet localized during evaporation or predefine the position of a residue speckle for probing by an X-ray beam.⁶

We report here the fabrication of SHS-chips based on a $0.5\ \mu\text{m}$ thick Si₃N₄ substrate ($\sim 99.9\%$ X-ray transmission) and $\sim 12\ \mu\text{m}$ high SU-8 photoresist pillars ($\sim 99.8\%$ X-ray transmission) showing also high optical and IR transmission. To explore the solution concentration capability of the chips, we probed a gold glyconanoparticle residue by nanobeam X-ray fluorescence (nanoXRF). As an example of a weakly scattering biomaterial, we studied a tobacco mosaic virus (TMV) residue by nanobeam X-ray diffraction (nanoXRD). The experimental protocol and setup are shown schematically in Fig. 1A and B.

Materials and methods

Device microfabrication

We fabricated three masks for generating (i) a matrix of Si₃N₄ membranes, (ii) a periodic hexagonal lattice of $10\ \mu\text{m}$ in diameter SU-8 pillars with a $30\ \mu\text{m}$ pitch⁸ and (iii) a non-periodic lattice of SU-8 pillars defined by an analytical function with the pillar separation decreasing towards the center of the chip thus inducing a gradient in wettability.^{5,6} We used a 2 inch $\langle 100 \rangle$ oriented silicon wafer with a $0.5\ \mu\text{m}$ Si₃N₄ layer on both sides. A photolithography step was used to protect the membrane

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from the following reactive ion etch (RIE) process uncovering the silicon according to the pattern of the 1st mask defining the Si-frames of the membranes of the individual chips. The silicon was removed by wet etching with KOH solution. A layer of SU-8 photoresist was then spin-coated on the wafer and structured by a 2nd photolithography process on the other side of the chip which involved an alignment step to match the pattern of the frames on the opposite side. The pillars and the Si₃N₄ membrane were covered with a ~20 nm thick Teflon (C₄F₈) layer by plasma deposition (ESI†).

The SHS-chips were characterized by optical microscopy and scanning electron microscopy (SEM) (Fig. 2A, B and 3A, B). We measured a contact angle for a 4 μ L water droplet of $\theta = 151.2^\circ$ on a periodic pillar SHS-chip (ESI†).

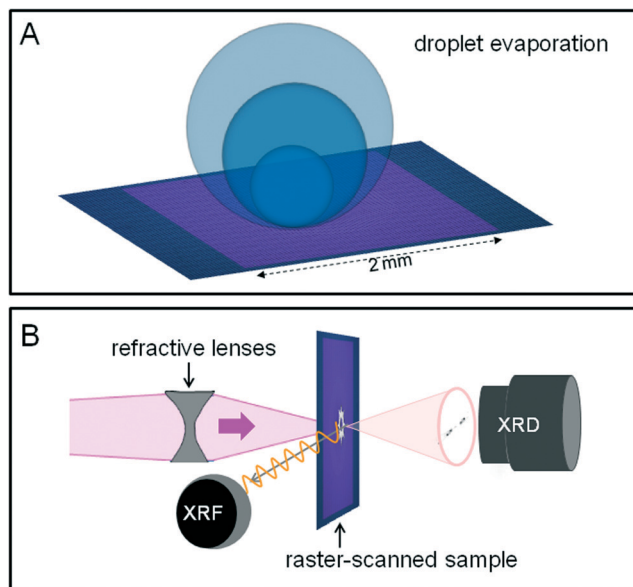


Fig. 1 A: A droplet (about 4 μ L) is evaporated on the Si₃N₄ membrane equipped with superhydrophobic SU-8 micropillars and the solute is concentrated. B: The schematic experimental setup allowing XRD and XRF experiments. The monochromatic beam from an undulator source is focused by refractive lenses⁷ on a submicron spot on the sample. The residue is raster-scanned through the nanobeam. An XRD pattern and an XRF spectrum (optionally) are recorded at every position.

Materials

Colloidal gold nanoparticles (AuNPs) with ligand-functionalized surfaces provide elements for bottom-up assembly of functional nanostructures which are of interest for mimicking biological systems.⁹ We deposited a ~4 μ L droplet of 5 nM gold glyconanoparticles in deionized water on the SHS-chip (Fig. 1A). The ~2.9 nm diameter particles consist of a 1.3 ± 0.3 nm diameter core corresponding on average to 71 gold atoms and were functionalized with a ~0.8 nm carbohydrate shell.¹⁰ We will use below the abbreviation Au₇₁NP (ESI†).

TMV is a plant-virus that forms filamentous structures.¹¹ The TMV particles have a rod-like shape of ~300 nm in length and ~18 nm in diameter.¹² We used a solution of 405 mg mL⁻¹ TMV particles in 1 mM EDTA solution + 0.1% azide, pH 7.2. The solution was diluted by a factor of 100 with deionized water. The deposited droplet volume was set also to ~4 μ L.

The SU-8 25 photoresist was obtained from MicroChem.

Synchrotron radiation experiments

A $\lambda = 0.08321$ nm monochromatic X-ray beam was focused on a ~170(h) \times 130(v) nm² spot by Si refractive lenses⁷ with a flux of $\sim 2 \times 10^9$ photons s⁻¹ at the sample position. Experiments were performed in transmission geometry with the beam normal to the substrate (Fig. 1B). XRF spectra were recorded in the horizontal scattering plane using a Si-drift detector. XRD data were collected using a CCD camera with an X-ray converter screen and 2K \times 2K pixels of 50 \times 50 μ m² each. The sample was step-scanned through the beam using an x/y/z piezo stage (ESI†). Background scattering from the substrate was very small and did not contribute discrete peaks or short-range order to the XRD patterns.

Results and discussion

NanoXRF probing of gold nanoparticles

Optical and SEM images of the Au₇₁NP residue on the non-periodic SHS-chip are shown in Fig. 3A and B. The composite XRF image (C-XRF) is composed of “pixels” scaled to the local integrated Au L _{α} band (Fig. 3C). The azimuthally integrated

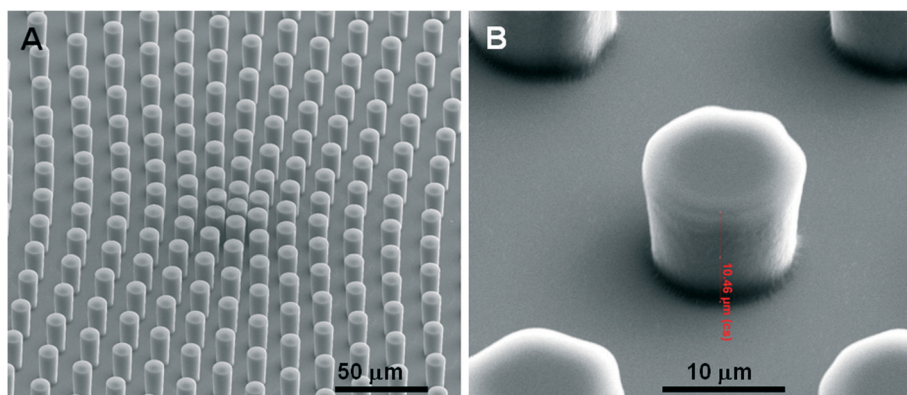


Fig. 2 A: A scanning electron microscopy (SEM) image of the central part of a non-periodic SU-8 pillar lattice on the Si₃N₄ substrate. B: A single SU-8 pillar of ~12 μ m in height. The pillars and substrate are covered with a ~20 nm layer of Teflon.



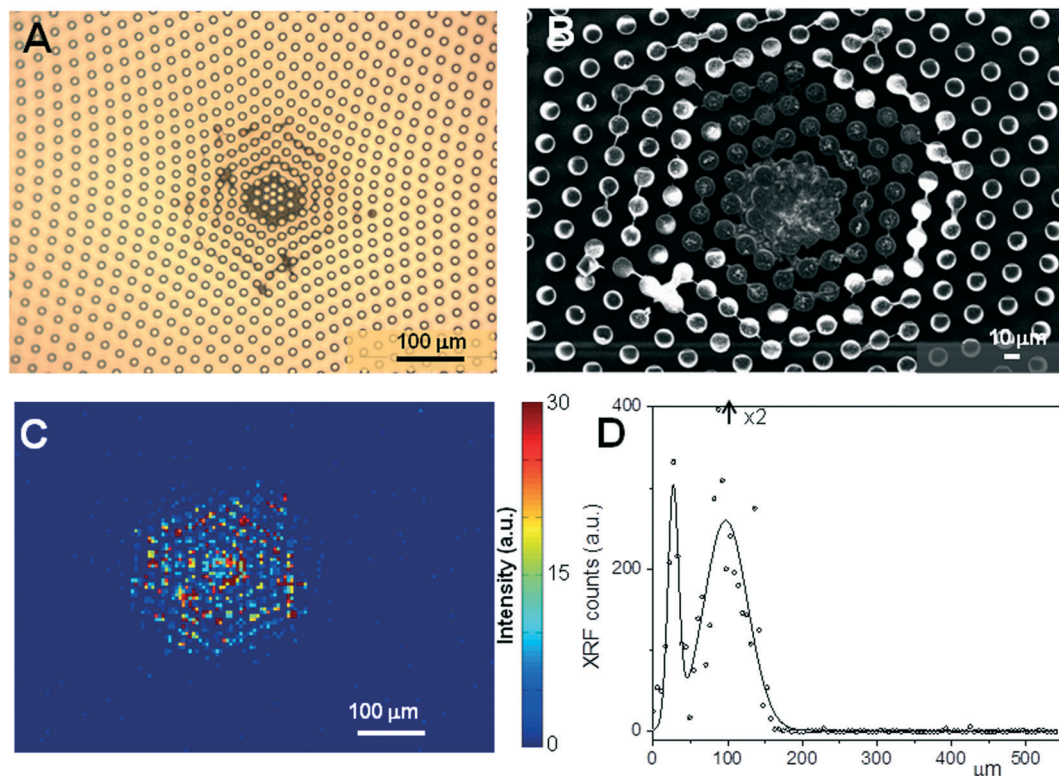


Fig. 3 A: An optical image of gold nanoparticles deposited on a non-periodic pillar SHS-chip. B: A SEM image of the inner part of SHS showing pillars interconnected by filaments. C: C-XRF corresponding to a step-resolution of 5 μm based on the Au L_{α} band. D: A radial XRF profile obtained by azimuthally integrating the C-XRF. Two Gaussian profiles have been fitted as guides to the eye. The center (0 μm) is defined at the highest pillar density (Fig. 2A).

XRF profile is shown in Fig. 3D. Two Gaussian profiles were fitted to the XRF profile suggesting two deposition zones around the chip center (Fig. 3D). The residue deposited close to the center of the gradient pattern extends radially to $\sim 50 \mu\text{m}$. This is surrounded by a broader residue distribution extending radially to $\sim 150 \mu\text{m}$. We attribute this to nanoparticles deposited at the contact line during the pinning transition. Although a number of pillars are connected by filaments (Fig. 3B), the nanoparticle concentration was not high enough to form a continuous coffee-ring type¹³ residue. The XRF profile shows complete confinement of the nanoparticles within the two zones. We note that for ultralow concentrations of organic and biological matter, the residue is only deposited in the central zone.⁵

Nanodiffraction probing of TMV nanorods

The optical image of a part of the TMV residue deposited on a periodic, pillared SHS-chip shows the formation of a coffee-ring type residue¹³ on the pillars (Fig. 4A). A composite XRD (C-XRD) image¹⁴ based on a raster scan with 0.5 μm steps is shown in Fig. 4B. Each “pixel” corresponds to a single diffraction pattern as the one shown in Fig. 4C. The observed reflections agree with the hexagonal TMV lattice with the nanorods oriented along the c -axis.¹⁵ A helical pitch of 2.202(5) nm derived from the $n = 3$ layer-line reflections confirms the small pitch reduction for dried TMV residues¹⁵ as compared to TMV sols.¹⁶

The limitation of the display range to the strongest low-order reflections on the $n = 0$ layer-line (Fig. 4C) implies that Ewald’s sphere¹⁷ is large with respect to interatomic distances and the reflection conditions are fulfilled for all patterns. Given a quasi-constant microstructure across the scanned area, the C-XRD image reflects in first order the mass density modulations projected on a plane normal to the beam direction.¹⁴

The C-XRD image reveals increased deposition around the inner-rim pillar as well as a narrow transition zone between the outer-rim pillar and the outer rim interface (Fig. 4B). There is also increased deposition in the area connecting the inner-rim and outer-rim pillars. We even observe in the optical and C-XRD images a thin residue layer on the outer-rim pillar which is the remnant of the retreating triple contact-line (Fig. 4A, B).

A more detailed microstructural analysis of the local nanorod orientation provides information on the arrested flow pattern of the nanorods. Indeed, we noted the formation of a macrodomain at the outer rim with the nanorod axes aligned parallel to the interface (Fig. 4D). Such an orientation has also been observed for the rim of a TMV coffee-ring on a glass substrate and attributed to capillary effects.¹⁵ A more detailed analysis of the arrested nanorod flow pattern is beyond the scope of the present note.

Conclusions

SHS-chips based on a thin Si_3N_4 membrane with periodic and non-periodic SU-8 photoresist pillar patterns have been



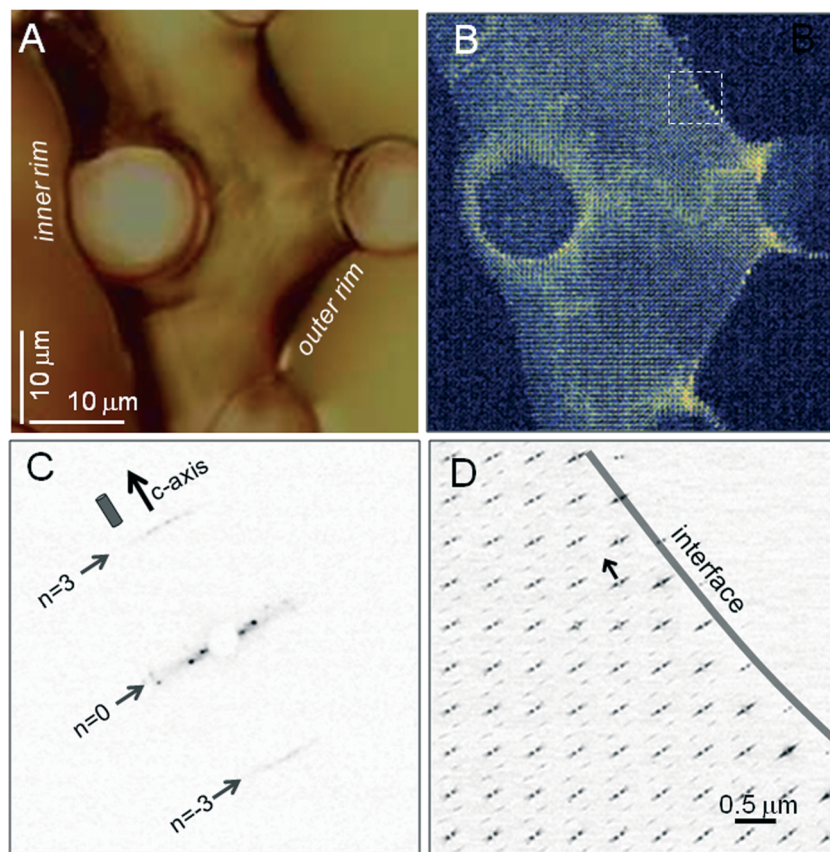


Fig. 4 A: An optical image of the TMV residue on periodic pillared SHS-chip. B: A C-XRD image based on an 81×81 “pixel” mesh scan with a $0.5 \mu\text{m}$ step size. C: A single XRD pattern from the outer-rim interface. The positions of the equator ($n = 0$) and $n = 3/-3$ layer lines are indicated. The c -axis direction (arrow) corresponds also to the direction of the long axis of the schematically depicted TMV nanorod.¹⁵ D: A C-XRD image of the dashed square in (B) with a schematic interface line. The upper display range is limited to the $n = 3/-3$ layer lines although scattering from the $n = 6/-6$ layers is also observed. The orientation of the local c -axis, corresponding to the TMV nanorod-axis, is indicated by an arrow.

fabricated and tested by nanobeam XRF and XRD. Well defined compaction of gold nanoparticles was obtained in the center of a non-periodic pillar pattern. The Si_3N_4 membrane and the SU-8 pillars show very high X-ray transmission and low background scattering. Weak diffraction signals from highly oriented TMV nanorods at the residue interface could be observed without background correction. Macrodomain formation by flow alignment could be explored for other large anisotropic biological objects in order to induce long-range order.

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